



# Software Evaluation of smart cards : Detection of abnormal behavior of a smart card application

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Figure : My research team :  
<http://www.epaymentbiometrics.ensicaen.fr/>



Figure : Castle of Caen

- Third year PhD student
- Laboratory : GREYC (computer science, electronic and electrical engineering)
- E-Payment & Biometrics
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Figure : Landing during the WWII



## Objectives

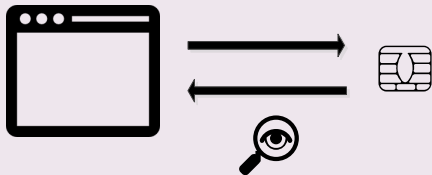


Figure : we focus on communication

- Evaluation of chips (a generic, easy and blackbox methodology)
- It is difficult for a campaign of intensive testing to trace the root reason of a malfunction of the smart card application
- A complementary method usable during a test phasis

- 1 Observation of the communication between the terminal and the chip
- 2 Definition of properties based on the theoretical behaviour of the chip's application
- 3 Detection of anomaly on the fly with the violation of properties



### Automat approach and Property approach

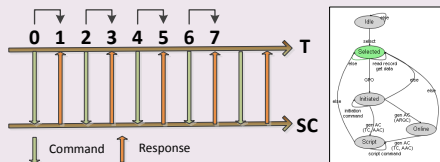


Figure : Automat conformance

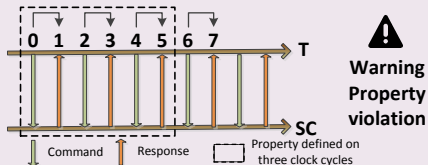


Figure : Property conformance

### Property Definition :

Germain Jolly, Sylvain Vernois and Jean-Luc Lambert, Improving Test Conformance of Smart Cards versus EMV-Specification by Using on the Fly Temporal Property Verification, 2014



# III Proof of concept with WSCT Framework

## View of the tool

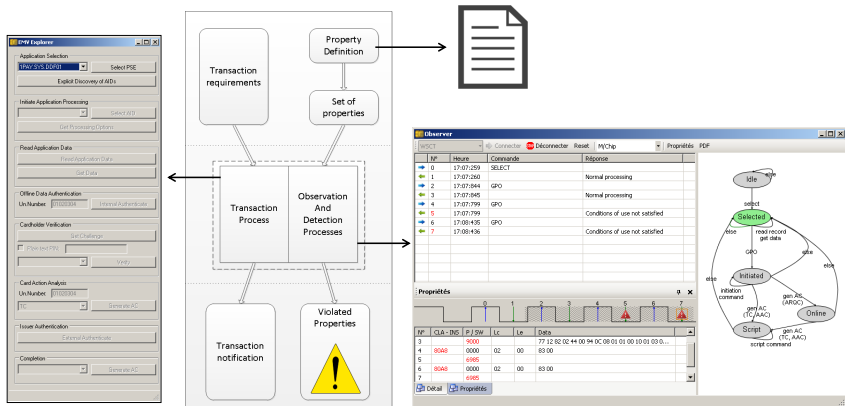
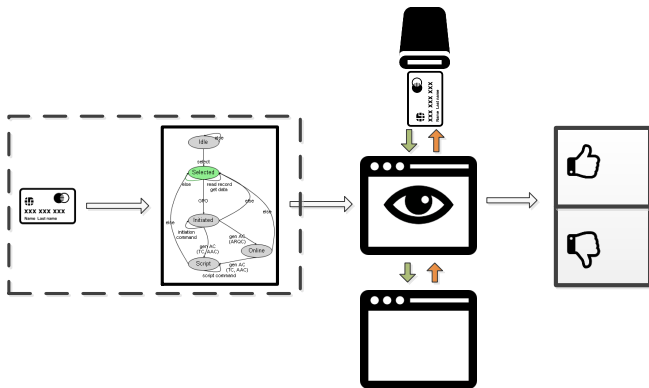


Figure : Proof of concept

Source code of WSCT Framework : <https://github.com/wsct>



I am currently working on generation of a complete collection of properties :

- from a model (theoretical machine state).
- from transactional flows (data mining approach).

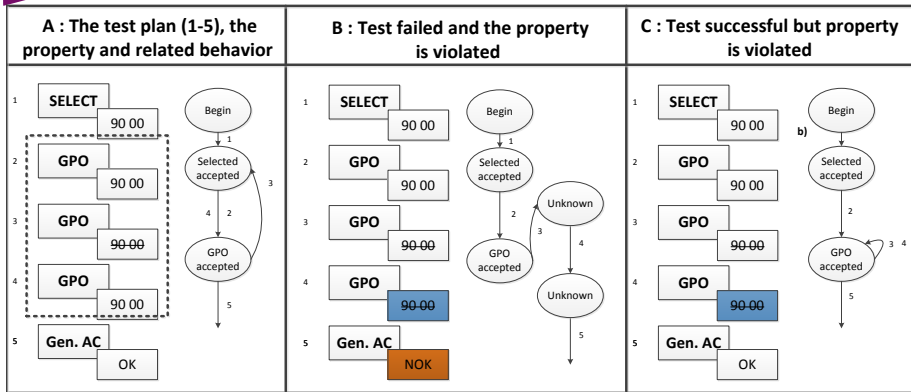
## Bibliography

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- M/Chip 4 Card Application Specifications for Credit and Debit, MasterCard International, 2002
- Un framework de fuzzing pour cartes a puce: application aux protocoles EMV, J. Lancia, 2011
- ISO/IEC 7816, International Organization for Standardization and the International Electrotechnical Commission
- Assertion-Based Design, Harry D. Foster, Adam C. Krolnik, David J. Lacey, 2010
- Source code of WSCT, <https://github.com/wsct>
- Analyse de la sécurité de transactions à puce avec le framework WinSCard Tools, Benoît Vibert, Vincent Alimi, Sylvain Vernois, 2012



## Annex :

### Link between APDU communication and the machine state



- **A** : Definition of the test plan (Gen. AC accepted) and the property
- **B** : We know why the Gen. AC has failed (see property)
- **C** : Even the test is successful, the application contains an error